

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10802735	TAKAFUJI ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Tran, Thien F	2811

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
257	59, 64, 66, 69, 70, 72, 347	12/21/06	TT
257	347-354, 507	03/15/07	TT

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Interference search history printout	03/15/07	TT

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>